

Dual P-channel MOSFET

ELM17801GA-S

■ General description

ELM17801GA-S uses advanced trench technology to provide excellent $R_{ds(on)}$, low gate charge and operation with gate voltages as low as 1.8V and internal ESD protection.

■ Features

- $V_{ds} = -20V$
- $I_d = -0.6A$ ($V_{gs} = -4.5V$)
- $R_{ds(on)} < 520m\Omega$ ($V_{gs} = -4.5V$)
- $R_{ds(on)} < 700m\Omega$ ($V_{gs} = -2.5V$)
- $R_{ds(on)} < 950m\Omega$ ($V_{gs} = -1.8V$)
- ESD Rating : 2000V HBM

■ Maximum absolute ratings

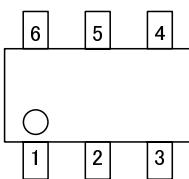
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	V_{ds}	-20	V	
Gate-source voltage	V_{gs}	± 8	V	
Continuous drain current	I_d	-0.60	A	1
Ta=70°C		-0.48		
Pulsed drain current	I_{dm}	-3	A	2
Power dissipation	P_d	0.30	W	1
Ta=70°C		0.19		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	°C	

■ Thermal characteristics

Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	t≤10s	$R_{\theta ja}$	360	415	°C/W	1
Maximum junction-to-ambient	Steady-state		400	460	°C/W	
Maximum junction-to-lead	Steady-state	$R_{\theta jl}$	300	350	°C/W	3

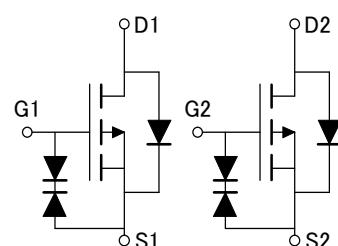
■ Pin configuration

SC-70-6 (TOP VIEW)



Pin No.	Pin name
1	SOURCE1
2	GATE1
3	DRAIN2
4	SOURCE2
5	GATE2
6	DRAIN1

■ Circuit



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■ Electrical characteristics

$T_a=25^\circ C$

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-source breakdown voltage	BVdss	$Id=-250\ \mu A, Vgs=0V$	-20			V
Zero gate voltage drain current	Idss	Vds=-16V			-1	μA
		Vgs=0V	Tj=55°C		-5	
Gate-source leakage current	Igss	Vds=0V, Vgs=±8V			±10	μA
Gate threshold voltage	Vgs(th)	Vds=Vgs, Id=-250 μA	-0.5	-0.6	-0.9	V
On state drain current	Id(on)	Vgs=-4.5V, Vds=-5V	-3			A
Static drain-source on-resistance	Rds(on)	Vgs=-4.5V		400	520	$m\Omega$
		Id=-0.6A	Tj=125°C	542	700	
		Vgs=-2.5V, Id=-0.5A		540	700	$m\Omega$
		Vgs=-1.8V, Id=-0.4A		700	950	$m\Omega$
Forward transconductance	Gfs	Vds=-5V, Id=-0.6A		1.7		S
Diode forward voltage	Vsd	Is=-0.5A, Vgs=0V		-0.86	-1.00	V
Max. body-diode continuous current	Is				-0.4	A
DYNAMIC PARAMETERS						
Input capacitance	Ciss	Vgs=0V, Vds=-10V, f=1MHz		114	140	pF
Output capacitance	Coss			17		pF
Reverse transfer capacitance	Crss			14		pF
Gate resistance	Rg	Vgs=0V, Vds=0V, f=1MHz		12	17	Ω
SWITCHING PARAMETERS						
Total gate charge	Qg	Vgs=-4.5V, Vds=-10V Id=-0.6A		1.44	1.80	nC
Gate-source charge	Qgs			0.14		nC
Gate-drain charge	Qgd			0.35		nC
Turn-on delay time	td(on)	Vgs=-4.5V, Vds=-10V Rl=16.7 Ω , Rgen=3 Ω		6.5		ns
Turn-on rise time	tr			6.5		ns
Turn-off delay time	td(off)			18.2		ns
Turn-off fall time	tf			5.5		ns
Body diode reverse recovery time	trr	If=-0.6A, dl/dt=100A/ μs		10	13	ns
Body diode reverse recovery charge	Qrr	If=-0.6A, dl/dt=100A/ μs		3		nC

NOTE :

1. The value of $R_{\theta ja}$ is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with $T_a=25^\circ C$. The value in any given applications depends on the user's specific board design, The current rating is based on the $t \leq 10s$ thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The $R_{\theta ja}$ is the sum of the thermal impedance from junction to lead $R_{\theta jl}$ and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_a=25^\circ C$. The SOA curve provides a single pulse rating.

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■ Typical electrical and thermal characteristics

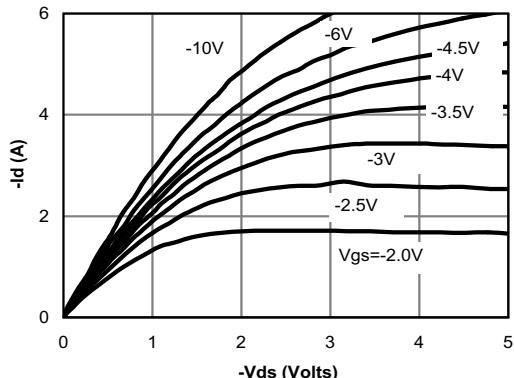


Fig 1: On-Region Characteristics

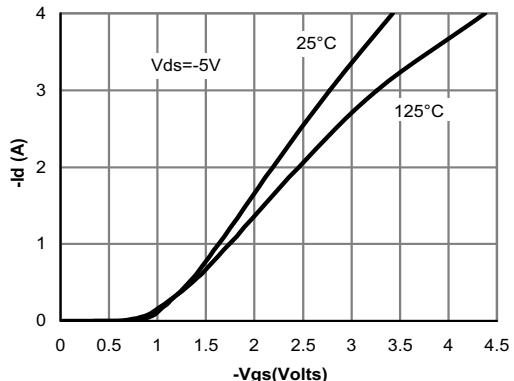


Figure 2: Transfer Characteristics

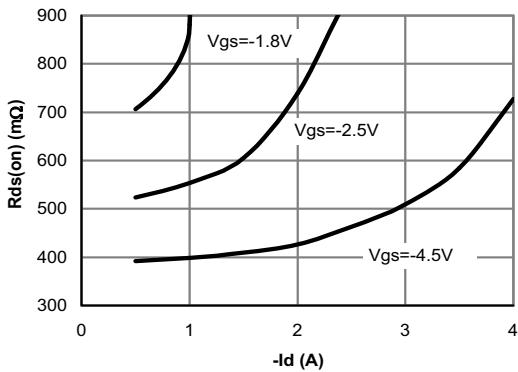


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

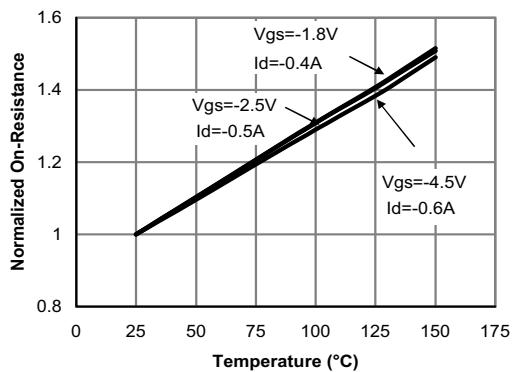


Figure 4: On-Resistance vs. Junction Temperature

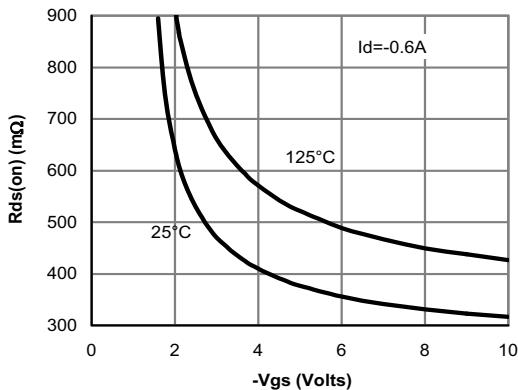


Figure 5: On-Resistance vs. Gate-Source Voltage

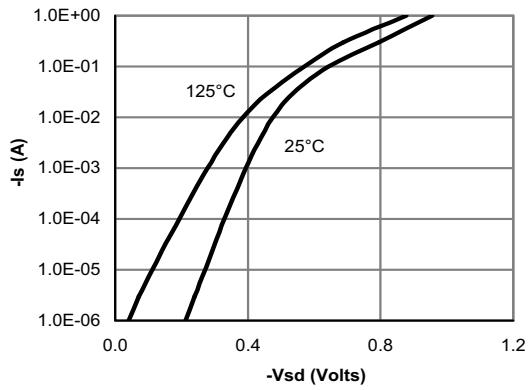


Figure 6: Body-Diode Characteristics

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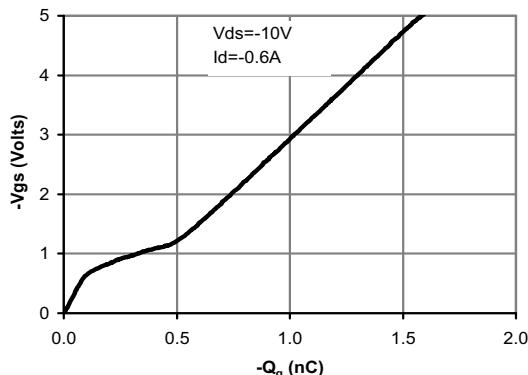


Figure 7: Gate-Charge Characteristics

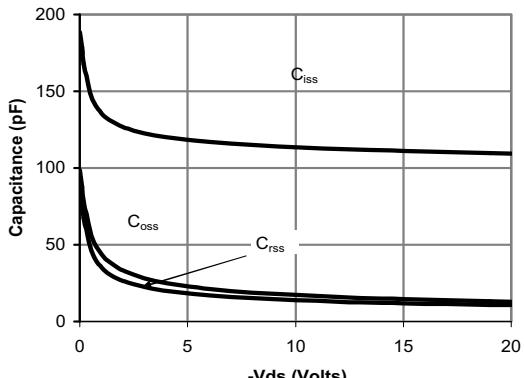


Figure 8: Capacitance Characteristics

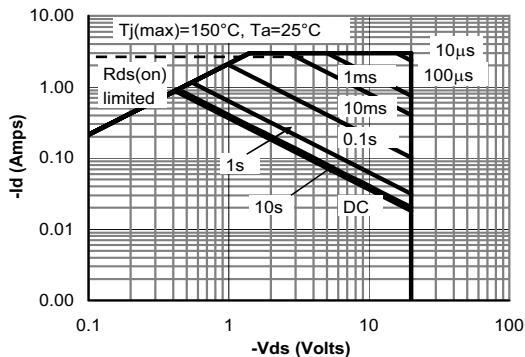


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

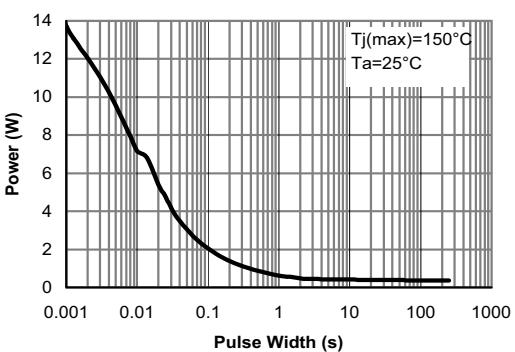


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

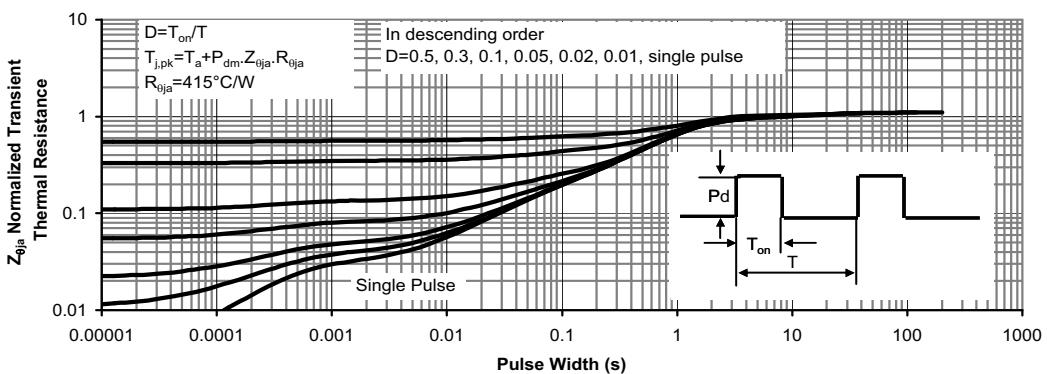


Figure 11: Normalized Maximum Transient Thermal Impedance